

FIG. 1

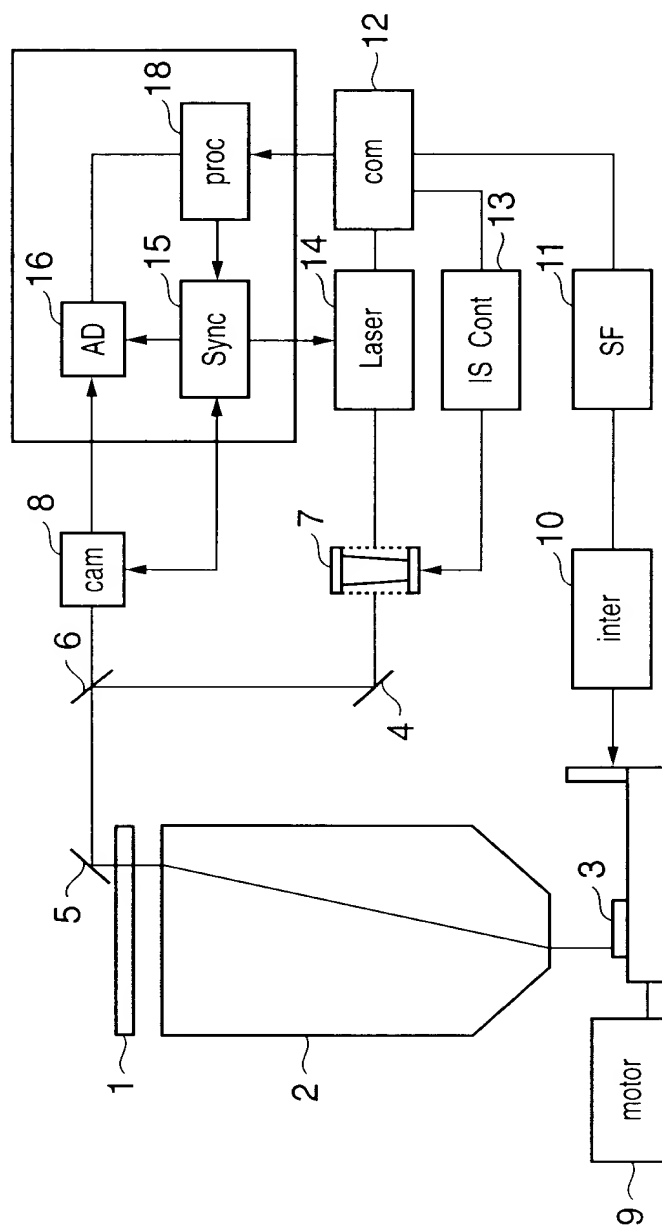


FIG. 2

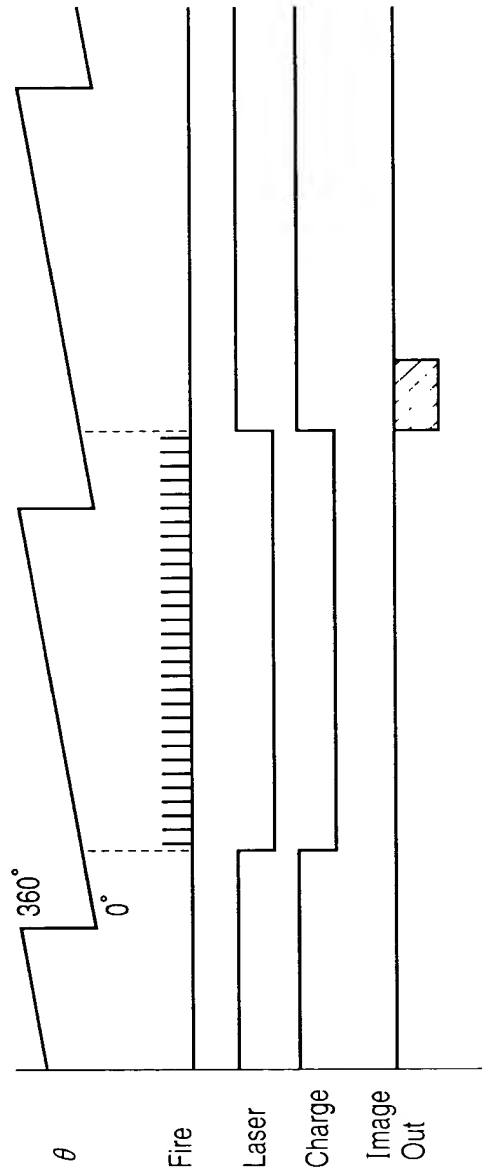


FIG. 3

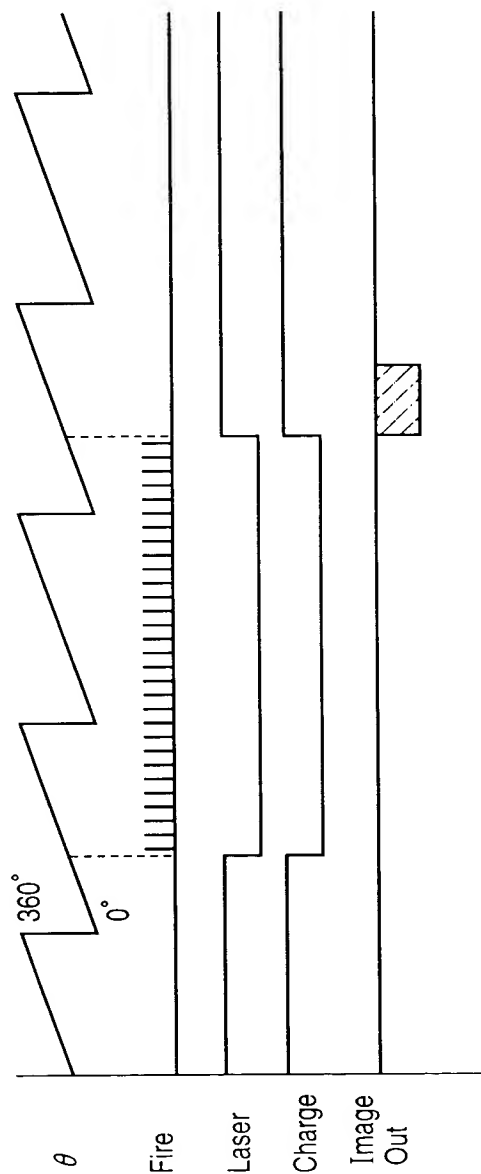


FIG. 4

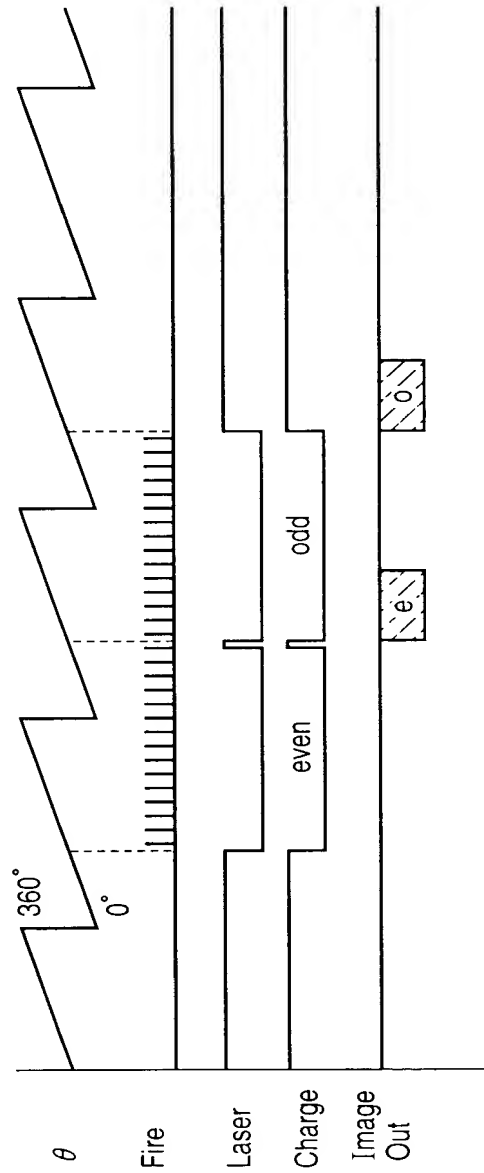


FIG. 5

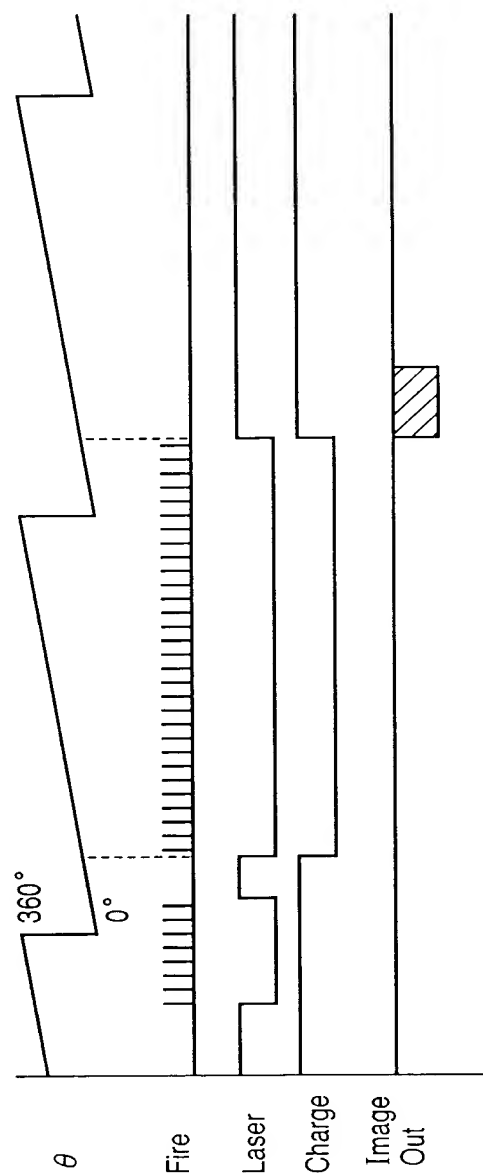


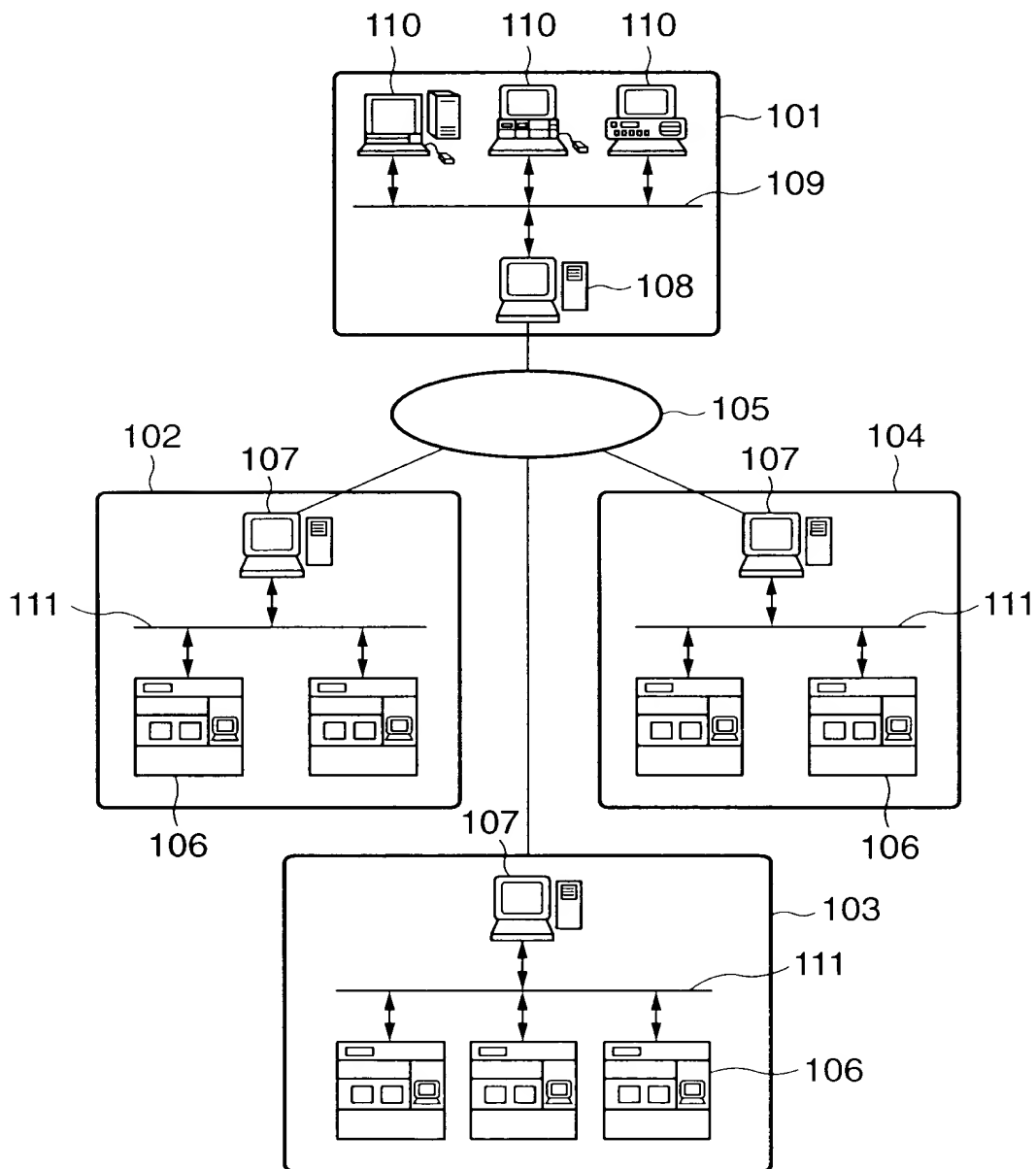
FIG. 6

FIG. 7

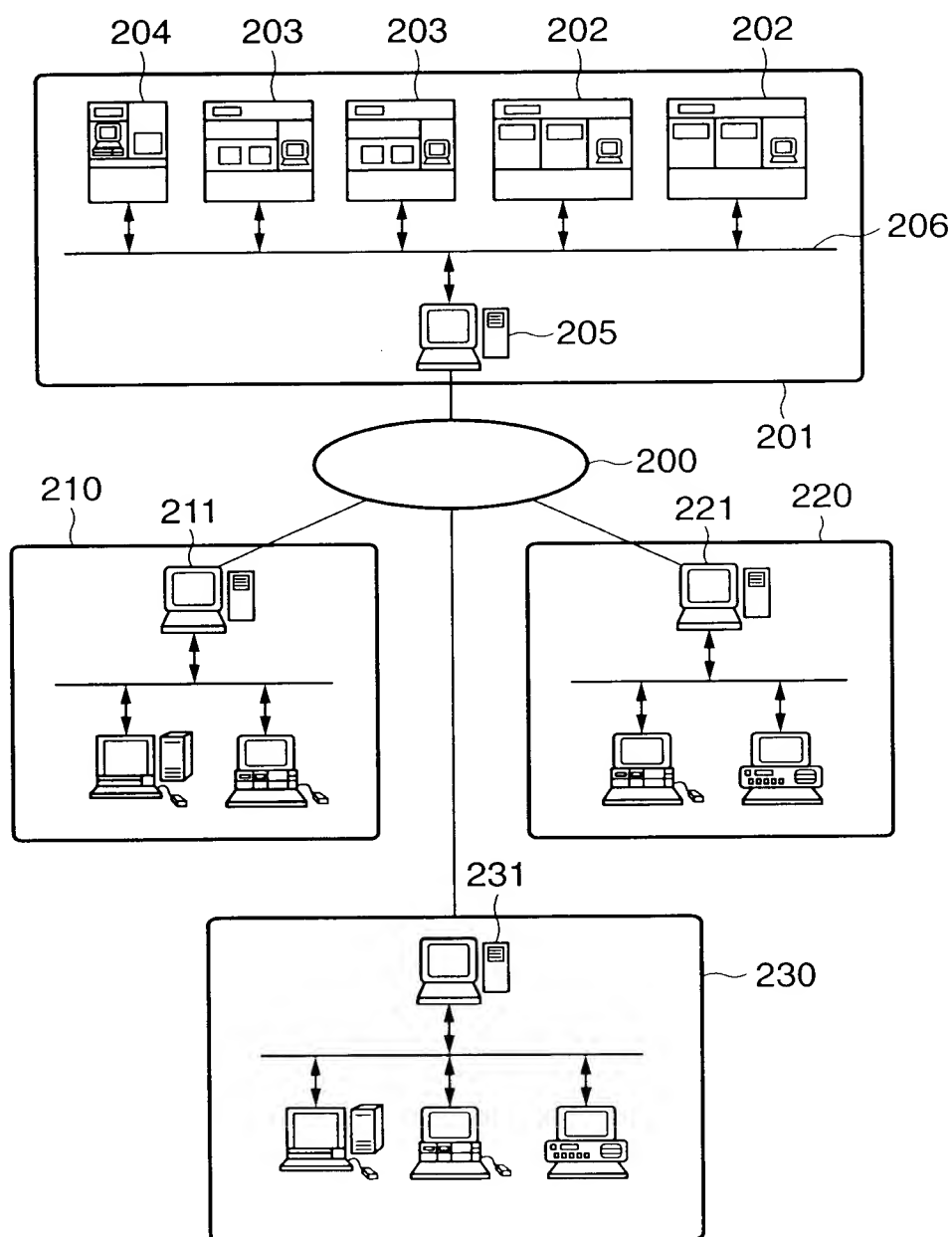


FIG. 8

URL

TROUBLE DB INPUT SCREEN

DATE OF OCCURRENCE 404

MODEL 401

SUBJECT 403

APPARATUS S/N 402

URGENCY 405

SYMPTOM 406

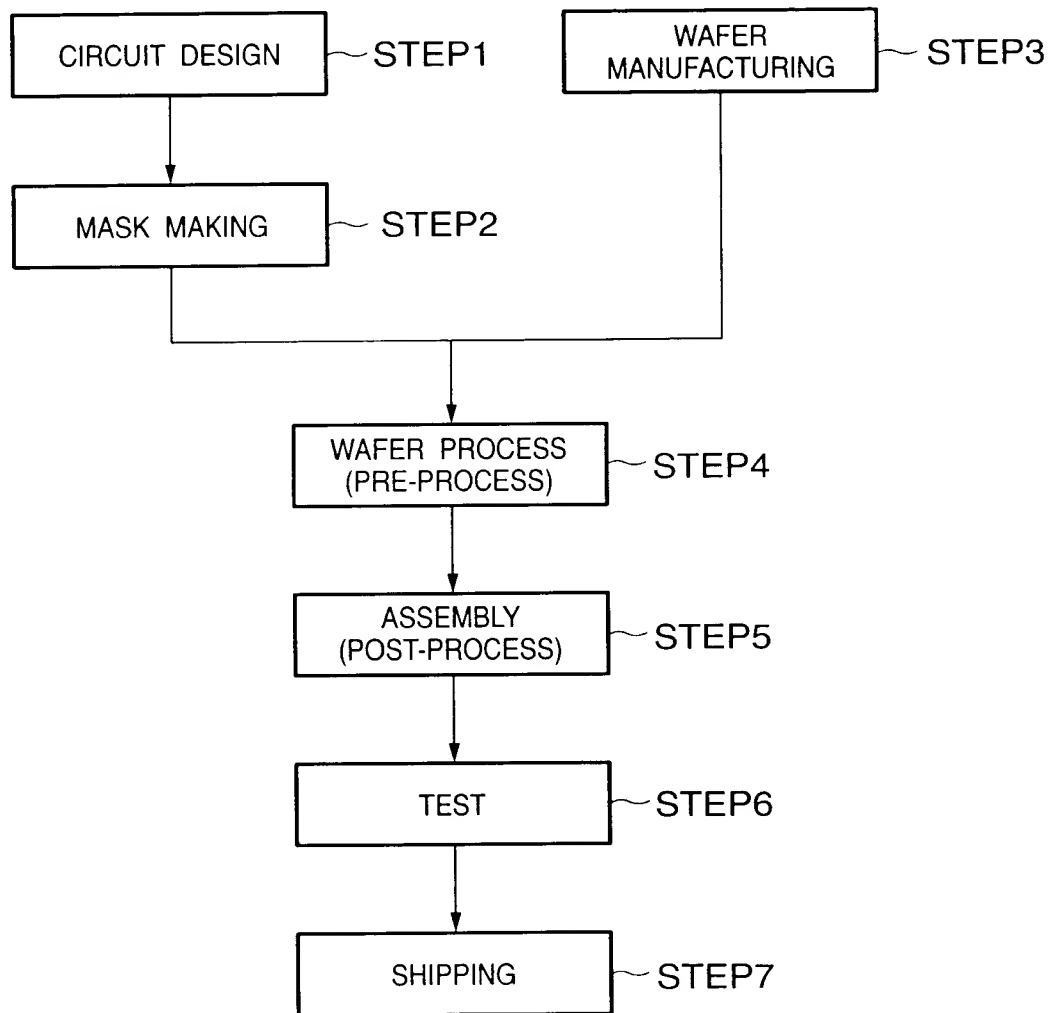
REMEDY 407

PROGRESS 408

410

411

412

FIG. 9

MANUFACTURE FLOW OF SEMICONDUCTOR DEVICE

FIG. 10

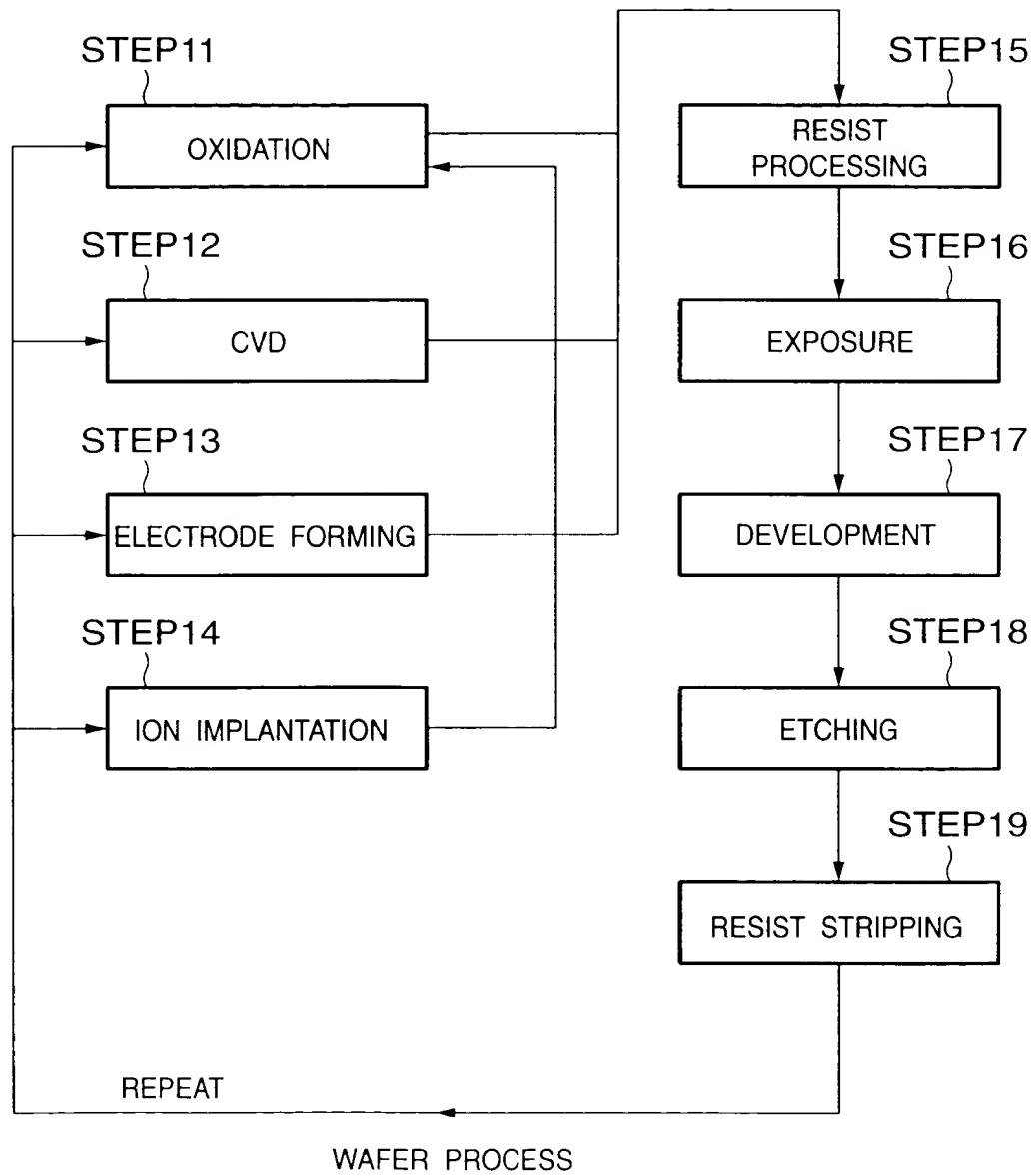


FIG. 11

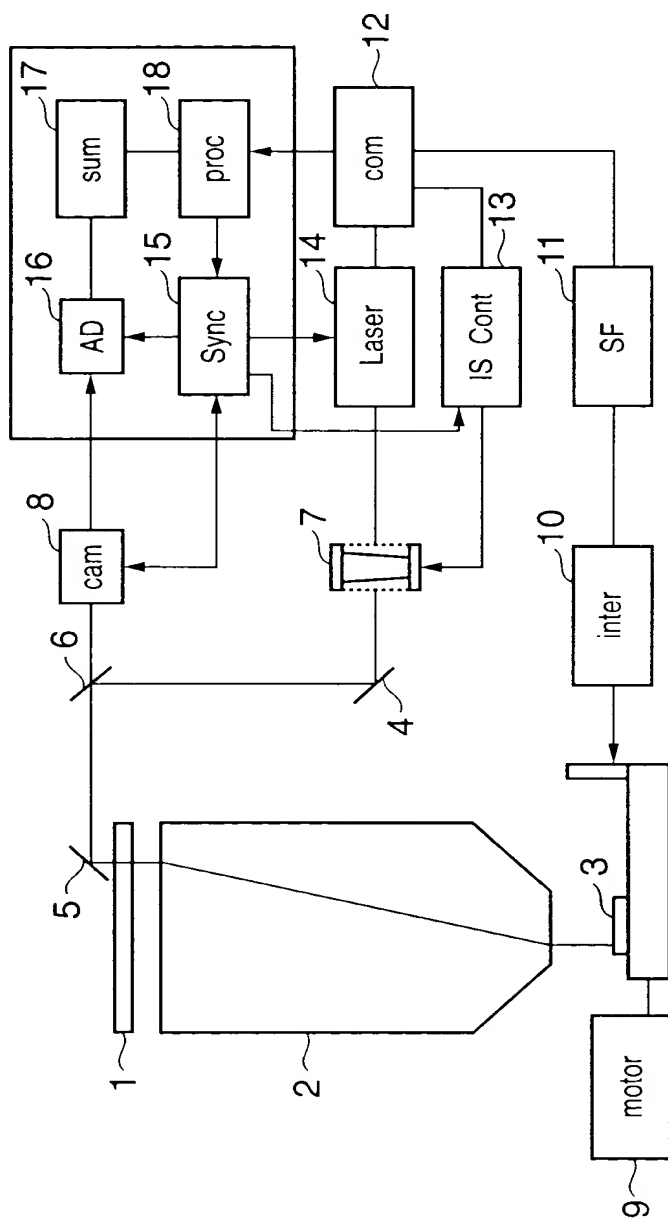


FIG. 12

